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APR 25 2006

**OFFICE OF PETITIONS**

In re Application of :  
Lee, et al. :  
Application No. 09/730,177 :  
Filed: December 5, 2000 :  
Attorney Docket No. SO-405 :

ON PETITION

This is a decision on the papers styled "Petition for Revival of a Patent Application No. 09/730,177 unavoidably abandoned", filed February 1, 2006, which has been treated as a petition under 37 C.F.R. § 1.137(a), to revive the unavoidably abandoned above-identified application.

The petition is dismissed.

Any request for reconsideration of this decision must be submitted within TWO (2) MONTHS from the mail date of this decision. Extensions of time under 37 CFR 1.136(a) are permitted. The reconsideration request should include a cover letter entitled "Renewed Petition under 37 CFR 1.137(a)."

This application became abandoned for failure to timely reply to the final Office action mailed May 21, 2004. Accordingly, this application became abandoned on August 22, 2004. A Notice of Abandonment was mailed on December 1, 2004.

The required \$250.00 petition fee (*see* 37 CFR 1.17(l)) has not been submitted. As such, the petition cannot be reviewed on the merits at this time and must be dismissed.

Further correspondence with respect to the instant petition under 37 CFR 1.137(a) should be addressed as follows:

By mail: Mail Stop Petition  
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By FAX: (571) 273-8300  
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Telephone inquiries should be directed to the undersigned at (571) 272-3228.



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for Patent Examination Policy